

# EVVOSEMI<sup>®</sup>

THINK CHANGE DO



ESD



TVS



MOS



LDO



Diode



Sensor



DC-DC

## Product Specification

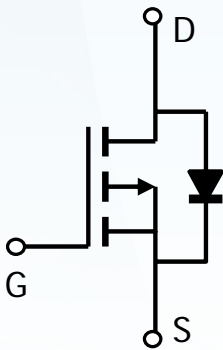
▶ Domestic	Part Number	AO4485
▶ Overseas	Part Number	AO4485
▶ Equivalent	Part Number	AO4485

EV is the abbreviation of name EVVO

P-Channel MOSFET

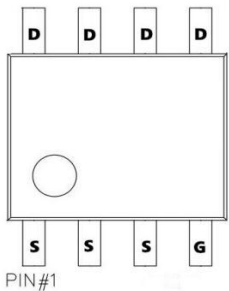
General Description

The AO4485 uses advanced trench technology to provide excellent  $R_{DS(ON)}$  with low gate charge. This device is suitable for use as a DC-DC converter application.



Features

- $V_{DS}$  (V) = -40V
- $I_D$  = -10A
- $R_{DS(ON)}$  < 15mΩ ( $V_{GS}$  = -10V)
- $R_{DS(ON)}$  < 20mΩ ( $V_{GS}$  = -4.5V)



Absolute Maximum Ratings  $T_J=25^{\circ}\text{C}$  unless otherwise noted

Parameter		Symbol	10 Sec	Steady State	Units
Drain-Source Voltage		V <sub>DS</sub>	-40		V
Gate-Source Voltage		V <sub>GS</sub>	±20		V
Continuous Drain Current <sup>A</sup>	T <sub>A</sub> =25°C	I <sub>D</sub>	-12	-10	A
	T <sub>A</sub> =70°C		-9	-8	
Pulsed Drain Current <sup>B</sup>		I <sub>DM</sub>	-120		
Avalanche Current <sup>G</sup>		I <sub>AR</sub>	-28		
Repetitive avalanche energy L=0.3mH <sup>G</sup>		E <sub>AR</sub>	118		mJ
Power Dissipation <sup>A</sup>	T <sub>A</sub> =25°C	P <sub>D</sub>	3.1	1.7	W
	T <sub>A</sub> =70°C		2.0	1.1	
Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to 150		°C

Thermal Characteristics

Parameter		Symbol	Typ	Max	Units
Maximum Junction-to-Ambient <sup>A</sup>	$t \leq 10\text{s}$	$R_{\theta JA}$	31	40	$^{\circ}\text{C/W}$
Maximum Junction-to-Ambient <sup>A</sup>	Steady State		59	75	$^{\circ}\text{C/W}$
Maximum Junction-to-Lead <sup>C</sup>	Steady State	$R_{\theta JL}$	16	24	$^{\circ}\text{C/W}$

## P-Channel MOSFET

### Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
<b>STATIC PARAMETERS</b>						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	I <sub>D</sub> = -250μA, V <sub>GS</sub> = 0V	-40			V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = -40V, V <sub>GS</sub> = 0V T <sub>J</sub> = 55°C			-1 -5	μA
I <sub>GSS</sub>	Gate-Body leakage current	V <sub>DS</sub> = 0V, V <sub>GS</sub> = ±20V			±100	nA
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = -250μA	-1	-1.5	-2.5	V
I <sub>D(ON)</sub>	On state drain current	V <sub>GS</sub> = -10V, V <sub>DS</sub> = -5V	-120			A
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> = -10V, I <sub>D</sub> = -10A V <sub>GS</sub> = -4.5V, I <sub>D</sub> = -8A		12.5 16	15 20	mΩ
g <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = -5V, I <sub>D</sub> = -10A		25		S
V <sub>SD</sub>	Diode Forward Voltage	I <sub>S</sub> = -1A, V <sub>GS</sub> = 0V		-0.7	-1	V
I <sub>S</sub>	Maximum Body-Diode Continuous Current				-3	A
<b>DYNAMIC PARAMETERS</b>						
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =-20V, f=1MHz		2500	3000	pF
C <sub>oss</sub>	Output Capacitance			260		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			180		pF
R <sub>g</sub>	Gate resistance	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz	2.5	4	6	Ω
<b>SWITCHING PARAMETERS</b>						
Q <sub>g</sub> (10V)	Total Gate Charge	V <sub>GS</sub> =-10V, V <sub>DS</sub> =-20V, I <sub>D</sub> =-10A		42	55	nC
Q <sub>g</sub> (4.5V)	Total Gate Charge			18.6		nC
Q <sub>gs</sub>	Gate Source Charge			7		nC
Q <sub>gd</sub>	Gate Drain Charge			8.6		nC
t <sub>D(on)</sub>	Turn-On DelayTime	V <sub>GS</sub> =-10V, V <sub>DS</sub> =-20V, R <sub>L</sub> = 2Ω, R <sub>GEN</sub> =3Ω		9.4		ns
t <sub>r</sub>	Turn-On Rise Time			20		ns
t <sub>D(off)</sub>	Turn-Off DelayTime			55		ns
t <sub>f</sub>	Turn-Off Fall Time			30		ns
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =-10A, dI/dt=100A/μs		38	49	ns
Q <sub>rr</sub>	Body Diode Reverse Recovery Charge	I <sub>F</sub> =-10A, dI/dt=100A/μs		47		nC

A: The value of R<sub>θJA</sub> is measured with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub> = 25°C. The value in any given application depends on the user's specific board design.

B: Repetitive rating, pulse width limited by junction temperature.

C: The R<sub>θJA</sub> is the sum of the thermal impedance from junction to lead R<sub>θJL</sub> and lead to ambient.

D: The static characteristics in Figures 1 to 6 are obtained using t ≤ 300μs pulses, duty cycle 0.5% max.

E: These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The SOA curve provides a single pulse rating.

F: The current rating is based on the t ≤ 10s thermal resistance rating.

G: E<sub>AR</sub> and I<sub>AR</sub> ratings are based on low frequency and duty cycles to keep T<sub>J</sub>=25°C.

## P-Channel MOSFET

### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

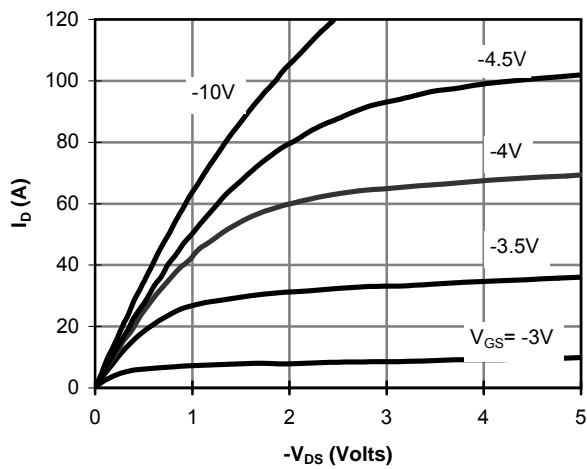


Figure 1: On-Region Characteristics

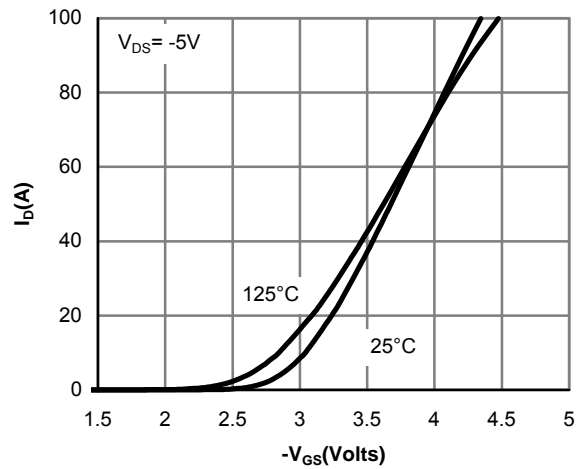


Figure 2: Transfer Characteristics

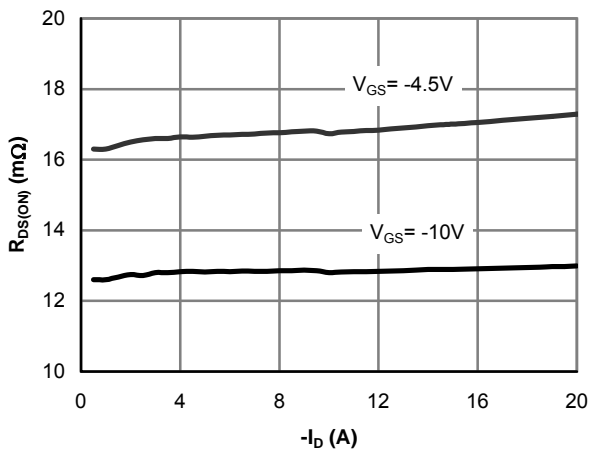


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

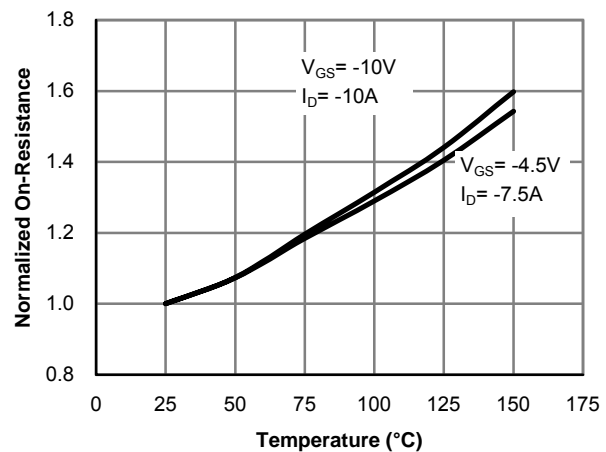


Figure 4: On-Resistance vs. Junction Temperature

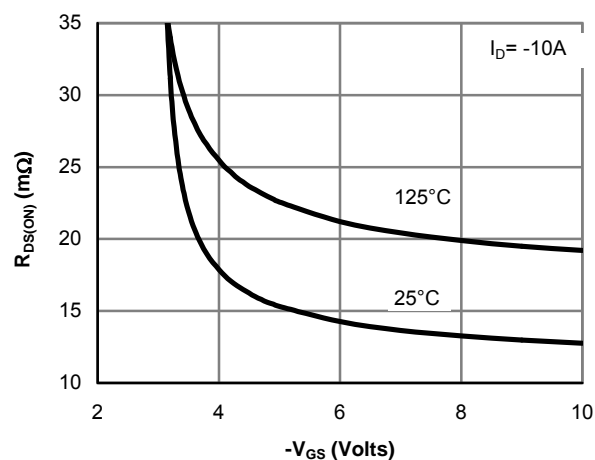


Figure 5: On-Resistance vs. Gate-Source Voltage

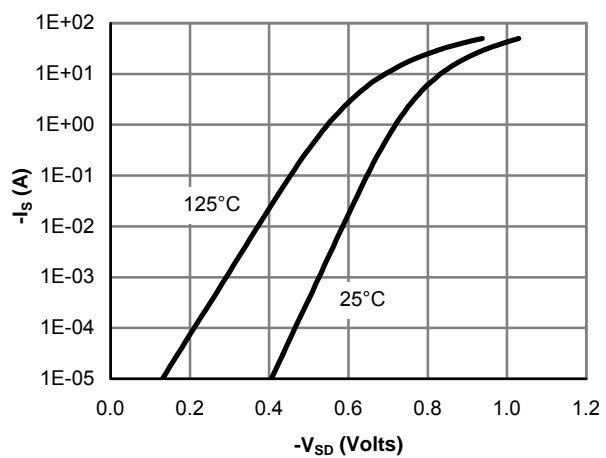
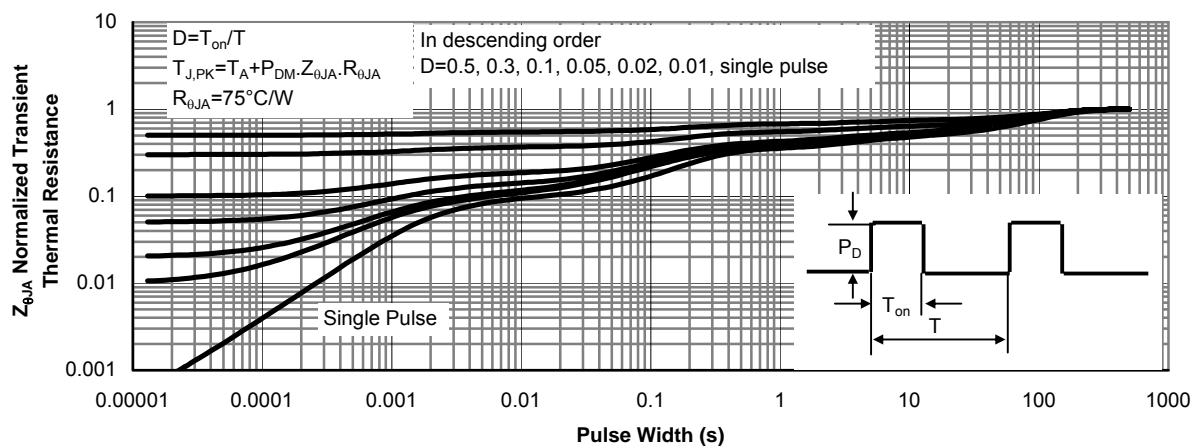
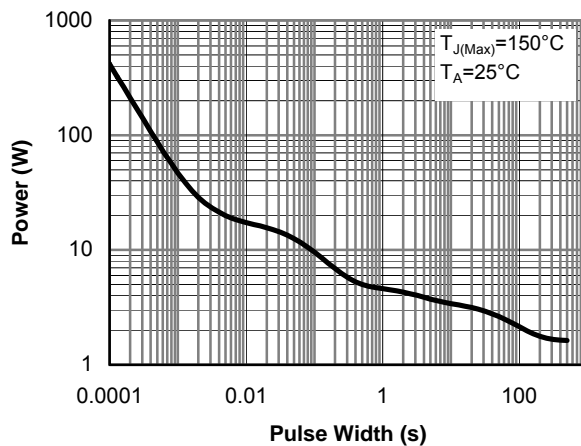
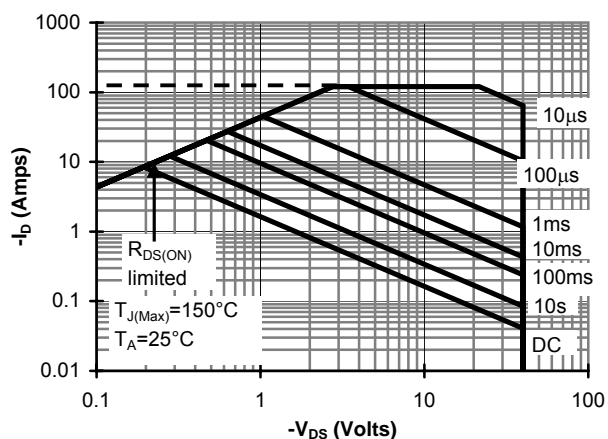
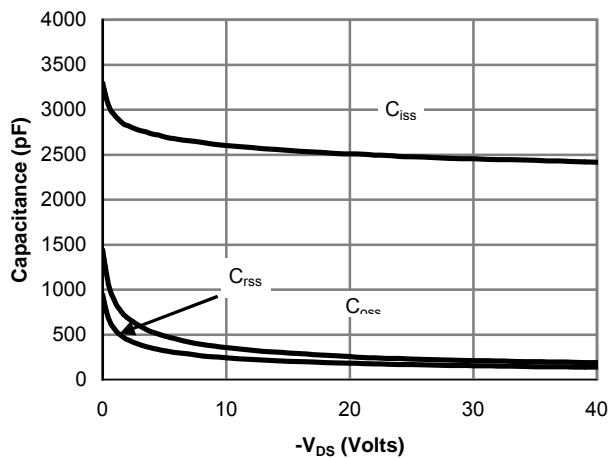
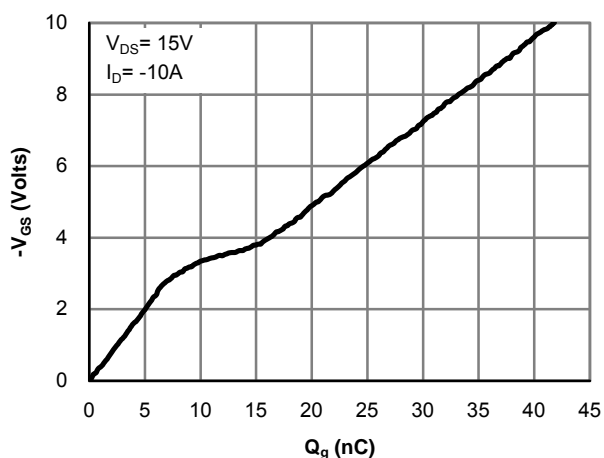
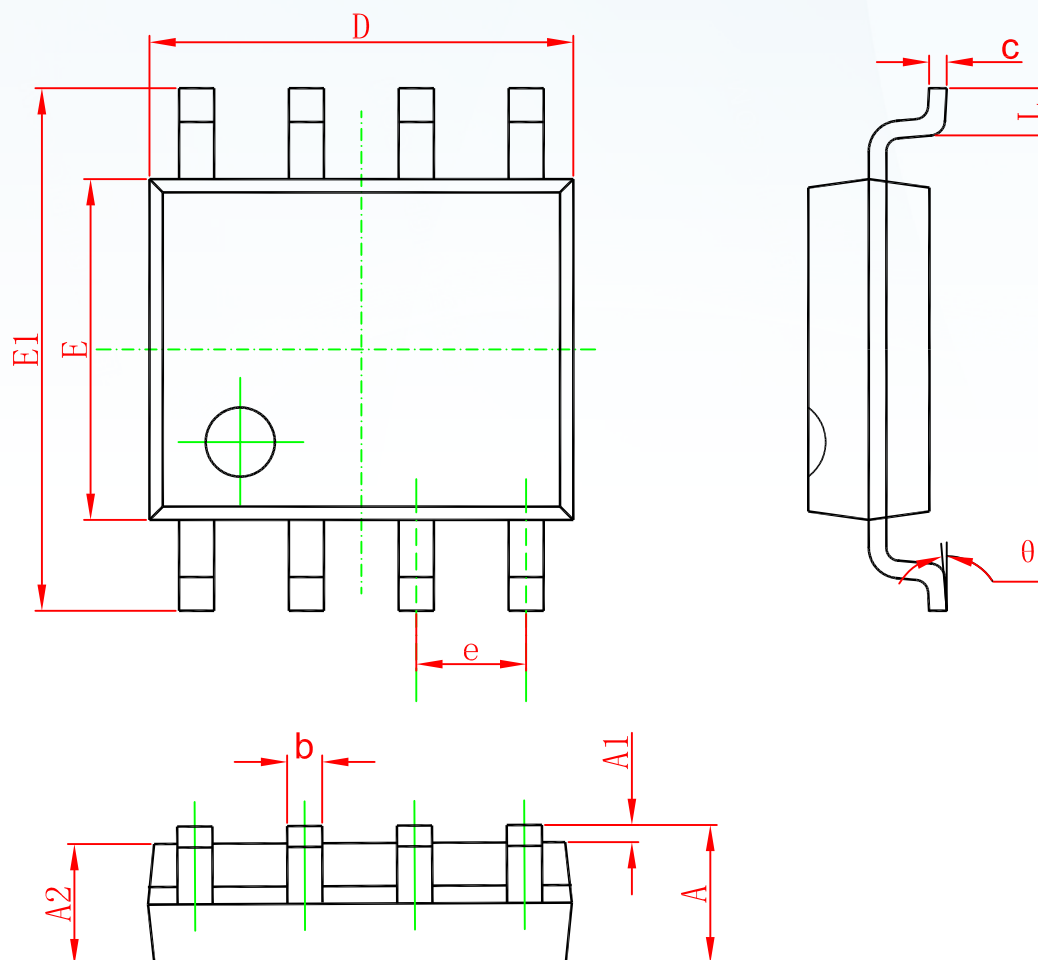


Figure 6: Body-Diode Characteristics

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### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

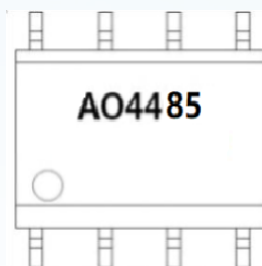


**P-Channel MOSFET**
**PACKAGE OUTLINE DIMENSIONS**
**SOP-8**


Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	1.350	1.750	0.053	0.069
A1	0.100	0.250	0.004	0.010
A2	1.350	1.550	0.053	0.061
b	0.330	0.510	0.013	0.020
c	0.170	0.250	0.006	0.010
D	4.700	5.100	0.185	0.200
E	3.800	4.000	0.150	0.157
E1	5.800	6.200	0.228	0.244
e	1.270(BSC)		0.050(BSC)	
L	0.400	1.270	0.016	0.050
θ	0°	8°	0°	8°

## P-Channel MOSFET

## Marking



## Ordering information

Order code	Package	Baseqty	Deliverymode
AO4485	SOP-8	3000	Tape and reel



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